

Search Notes

Application/Control No.

10/648,945

Examiner

Jezia Riley

Applicant(s)/Patent under
Reexamination

BAZAN ET AL.

Art Unit

1637

SEARCHED

Class	Subclass	Date	Examiner
435	6		
536	22.1,23.1		
536	24.3,26.6	4/30/2007	JR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
435	6	//	//
536	22.1,23.1	//	//
536	24.3,26.6	4/30/2007	JR

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR